

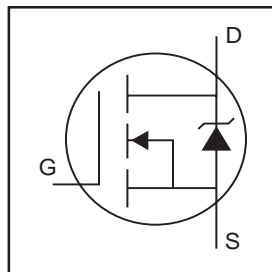
International  
**IR** Rectifier

PD-91317C

**IRLR/U2705**

HEXFET® Power MOSFET

- Logic-Level Gate Drive
- Ultra Low On-Resistance
- Surface Mount (IRLR2705)
- Straight Lead (IRLU2705)
- Advanced Process Technology
- Fast Switching
- Fully Avalanche Rated



$$V_{DS} = 55V$$

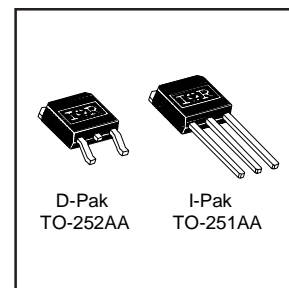
$$R_{DS(on)} = 0.040\Omega$$

$$I_D = 28A⑤$$

### Description

Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve the lowest possible on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient device for use in a wide variety of applications.

The D-PAK is designed for surface mounting using vapor phase, infrared, or wave soldering techniques. The straight lead version (IRFU series) is for through-hole mounting applications. Power dissipation levels up to 1.5 watts are possible in typical surface mount applications.



D-Pak  
TO-252AA

I-Pak  
TO-251AA

### Absolute Maximum Ratings

	Parameter	Max.	Units
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	28	A
$I_D @ T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	20	
$I_{DM}$	Pulsed Drain Current ①	110	
$P_D @ T_C = 25^\circ C$	Power Dissipation	68	W
	Linear Derating Factor	0.45	W/°C
$V_{GS}$	Gate-to-Source Voltage	$\pm 16$	V
$E_{AS}$	Single Pulse Avalanche Energy ②	110	mJ
$I_{AR}$	Avalanche Current ①	16	A
$E_{AR}$	Repetitive Avalanche Energy ①	6.8	mJ
$dv/dt$	Peak Diode Recovery $dv/dt$ ③	5.0	V/ns
$T_J$	Operating Junction and	-55 to + 175	°C
$T_{STG}$	Storage Temperature Range		
	Soldering Temperature, for 10 seconds	300 (1.6mm from case )	

### Thermal Resistance

	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	—	2.2	°C/W
$R_{\theta JA}$	Case-to-Ambient (PCB mount)**	—	50	
$R_{\theta JA}$	Junction-to-Ambient	—	110	

\*\* When mounted on 1" square PCB (FR-4 or G-10 Material) .

For recommended footprint and soldering techniques refer to application note #AN-994

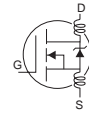
[www.irf.com](http://www.irf.com)

1

4/1/03

Electrical Characteristics @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	55	—	—	V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	0.065	—	V/°C	Reference to $25^\circ\text{C}$ , $I_D = 1mA$
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	—	—	0.040	W	$V_{GS} = 10V, I_D = 17A$ ④
		—	—	0.051		$V_{GS} = 5.0V, I_D = 17A$ ④
		—	—	0.065		$V_{GS} = 4.0V, I_D = 14A$ ④
$V_{GS(th)}$	Gate Threshold Voltage	1.0	—	2.0	V	$V_{DS} = V_{GS}, I_D = 250\mu A$
$g_{fs}$	Forward Transconductance	11	—	—	S	$V_{DS} = 25V, I_D = 16A$ ⑦
$I_{DSS}$	Drain-to-Source Leakage Current	—	—	25	$\mu A$	$V_{DS} = 55V, V_{GS} = 0V$
		—	—	250		$V_{DS} = 44V, V_{GS} = 0V, T_J = 150^\circ\text{C}$
$I_{GSS}$	Gate-to-Source Forward Leakage	—	—	100	nA	$V_{GS} = 16V$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{GS} = -16V$
$Q_g$	Total Gate Charge	—	—	25	nC	$I_D = 16A$
$Q_{gs}$	Gate-to-Source Charge	—	—	5.2		$V_{DS} = 44V$
$Q_{gd}$	Gate-to-Drain ("Miller") Charge	—	—	14		$V_{GS} = 5.0V$ , See Fig. 6 and 13 ④ ⑦
$t_{d(on)}$	Turn-On Delay Time	—	8.9	—	ns	$V_{DD} = 28V$
$t_r$	Rise Time	—	100	—		$I_D = 16A$
$t_{d(off)}$	Turn-Off Delay Time	—	21	—		$R_G = 6.5\Omega, V_{GS} = 5.0V$
$t_f$	Fall Time	—	29	—		$R_D = 1.8\Omega$ , See Fig. 10 ④ ⑦
$L_D$	Internal Drain Inductance	—	4.5	—	nH	Between lead, 6mm (0.25in.) from package and center of die contact ⑥
$L_S$	Internal Source Inductance	—	7.5	—		
$C_{iss}$	Input Capacitance	—	880	—	pF	$V_{GS} = 0V$
$C_{oss}$	Output Capacitance	—	220	—		$V_{DS} = 25V$
$C_{rss}$	Reverse Transfer Capacitance	—	94	—		$f = 1.0MHz$ , See Fig. 5 ⑦



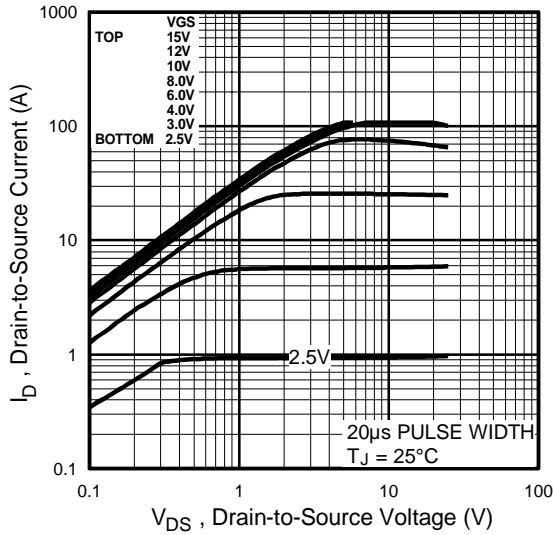
## Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_S$	Continuous Source Current (Body Diode)	—	—	28	A	MOSFET symbol showing the integral reverse p-n junction diode.
$I_{SM}$	Pulsed Source Current (Body Diode) ①	—	—	110		
$V_{SD}$	Diode Forward Voltage	—	—	1.3	V	$T_J = 25^\circ\text{C}, I_S = 17A, V_{GS} = 0V$ ④
$t_{rr}$	Reverse Recovery Time	—	76	110	ns	$T_J = 25^\circ\text{C}, I_F = 16A$
$Q_{rr}$	Reverse Recovery Charge	—	190	290	nC	$di/dt = 100A/\mu s$ ④ ⑦
$t_{on}$	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S + L_D$ )				

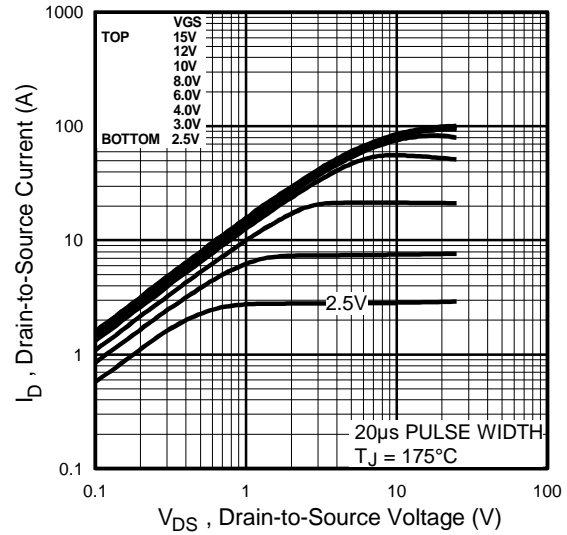
## Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. ( See fig. 11 )
- ②  $V_{DD} = 25V$ , starting  $T_J = 25^\circ\text{C}$ ,  $L = 610\mu H$   
 $R_G = 25\Omega, I_{AS} = 16A$ . (See Figure 12)
- ③  $I_{SD} \leq 16A$ ,  $di/dt \leq 270A/\mu s$ ,  $V_{DD} \leq V_{(BR)DSS}$ ,  
 $T_J \leq 175^\circ\text{C}$
- ④ Pulse width  $\leq 300\mu s$ ; duty cycle  $\leq 2\%$ .

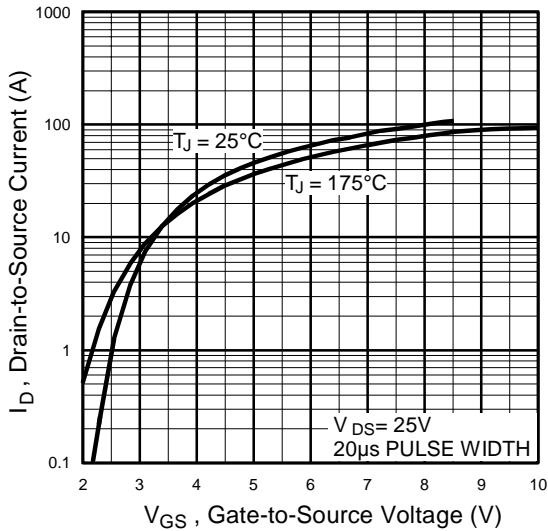
- ⑤ Calculated continuous current based on maximum allowable junction temperature; Package limitation current = 20A.
- ⑥ This is applied for I-PAK,  $L_S$  of D-PAK is measured between lead and center of die contact.
- ⑦ Uses IRLZ34N data and test conditions.



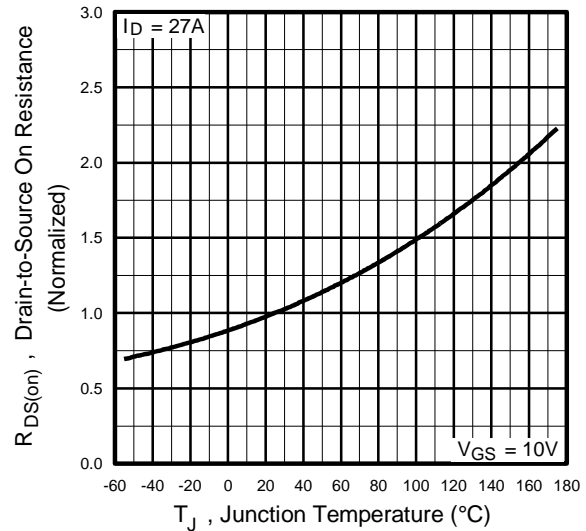
**Fig 1.** Typical Output Characteristics



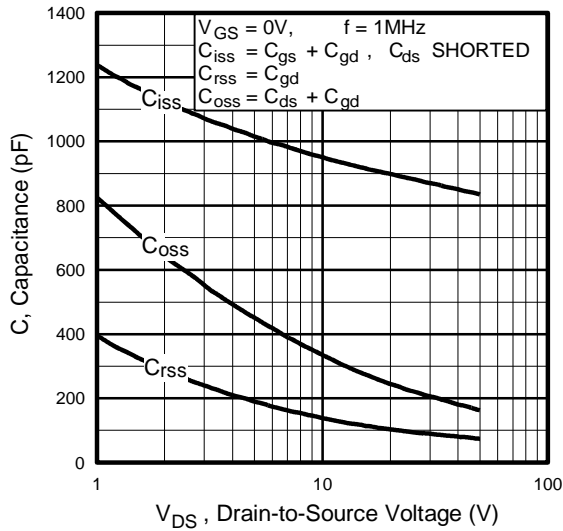
**Fig 2.** Typical Output Characteristics



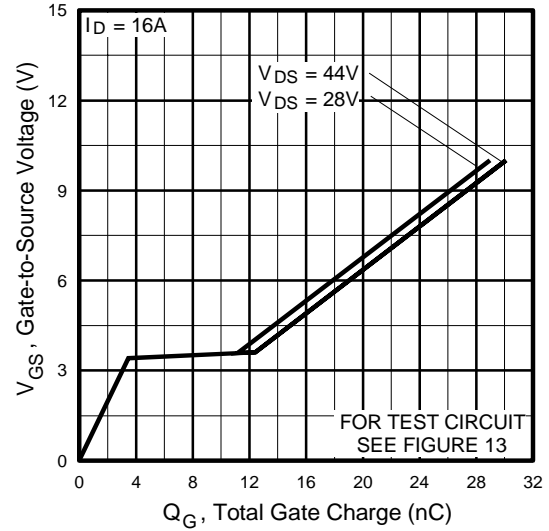
**Fig 3.** Typical Transfer Characteristics



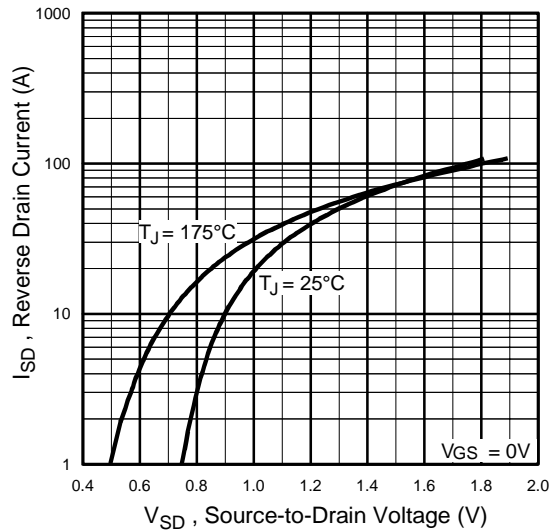
**Fig 4.** Normalized On-Resistance  
Vs. Temperature



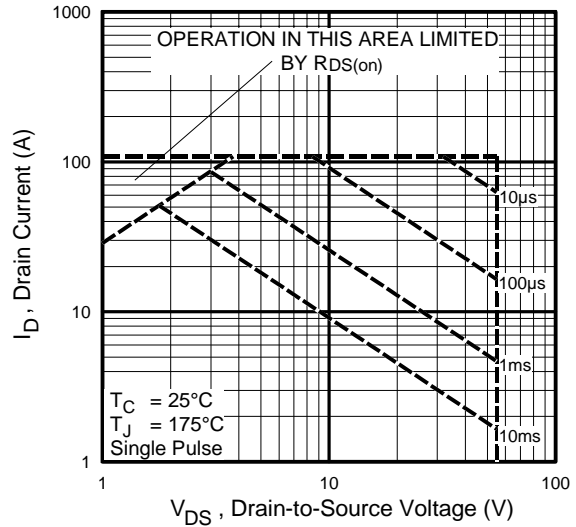
**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage



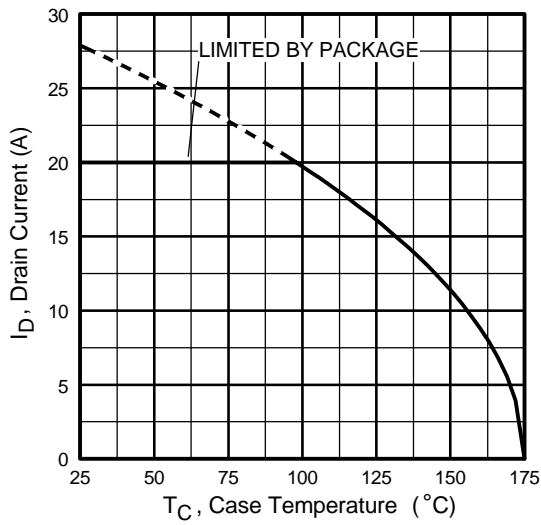
**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage



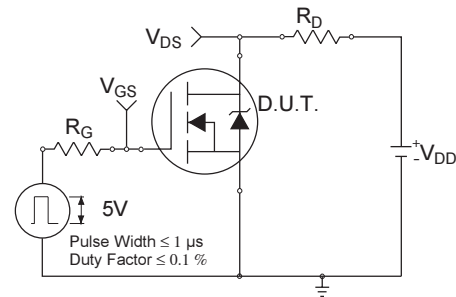
**Fig 7.** Typical Source-Drain Diode Forward Voltage



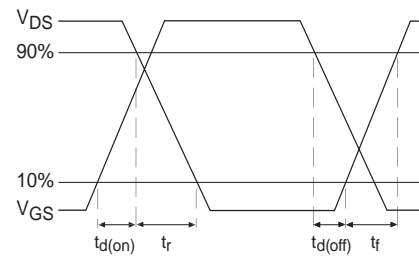
**Fig 8.** Maximum Safe Operating Area



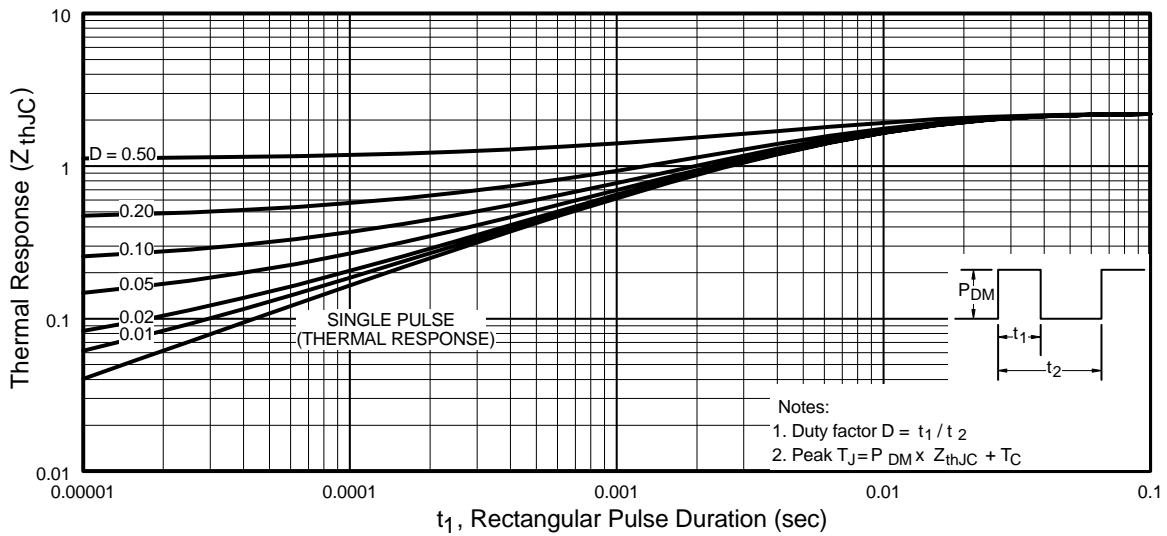
**Fig 9.** Maximum Drain Current Vs. Case Temperature



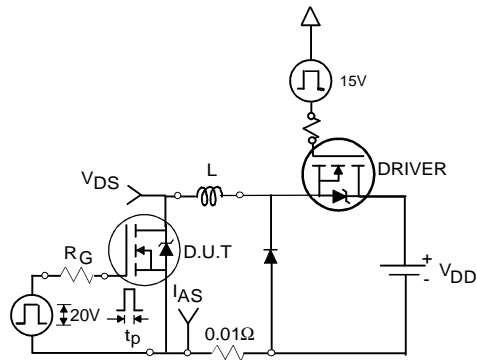
**Fig 10a.** Switching Time Test Circuit



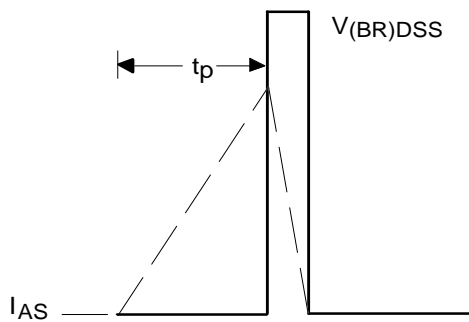
**Fig 10b.** Switching Time Waveforms



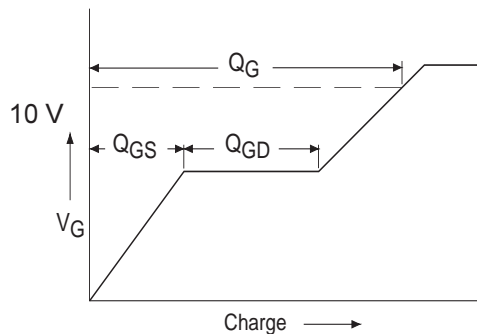
**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case



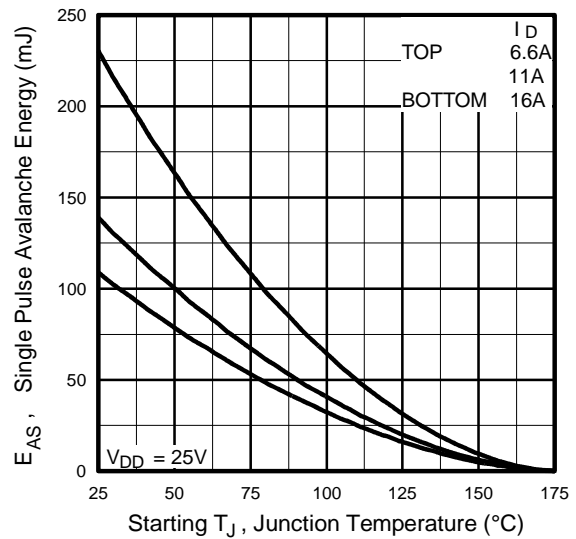
**Fig 12a.** Unclamped Inductive Test Circuit



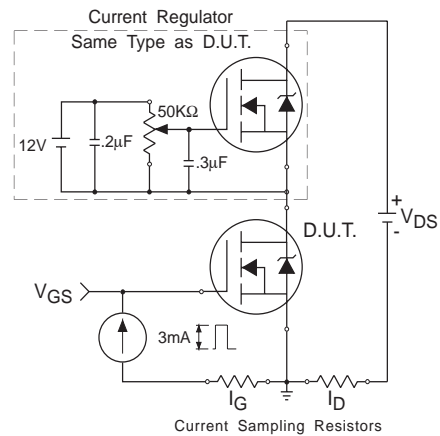
**Fig 12b.** Unclamped Inductive Waveforms



**Fig 13a.** Basic Gate Charge Waveform

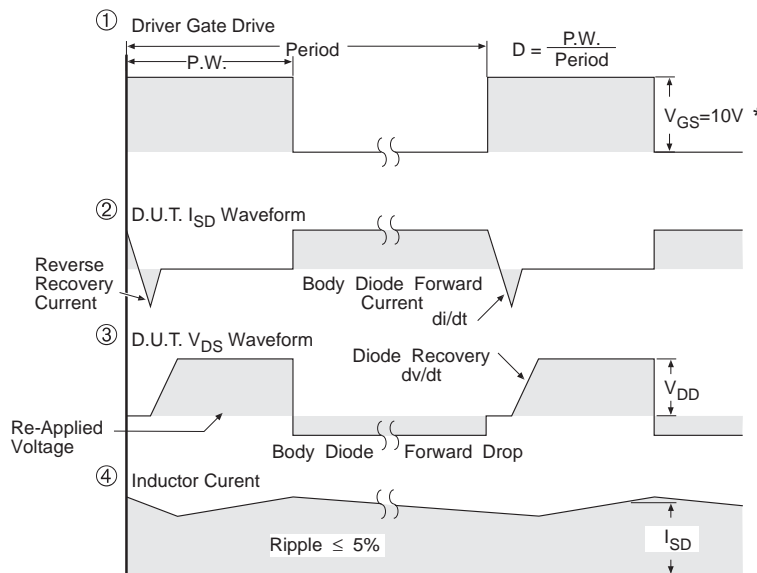
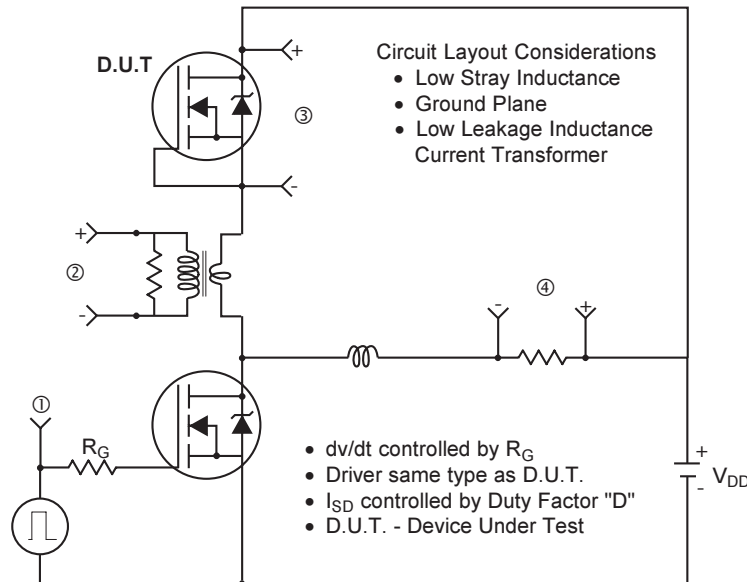


**Fig 12c.** Maximum Avalanche Energy  
Vs. Drain Current



**Fig 13b.** Gate Charge Test Circuit

### Peak Diode Recovery $dv/dt$ Test Circuit



\*  $V_{GS} = 5V$  for Logic Level Devices

**Fig 14.** For N-Channel HEXFETS

International  
**IOR** Rectifier

## TO-252AA Outline

Technical drawing of a mechanical part, likely a connector or plug, showing front and side views with dimensions in inches and millimeters.

**Front View Dimensions:**

- Overall width: 6.73 (.265)
- Top flange width: 6.35 (.250)
- Top flange height: 1.27 (.050)
- Top flange thickness: 0.88 (.035)
- Top flange hole diameter: 5.46 (.215)
- Top flange hole offset: 5.21 (.205)
- Top flange hole diameter: 1.02 (.040)
- Top flange hole offset: 1.64 (.025)
- Top flange hole diameter: 1.52 (.060)
- Top flange hole offset: 1.15 (.045)
- Top flange hole diameter: 1.14 (.045)
- Top flange hole offset: 0.76 (.030)
- Top flange hole diameter: 2.28 (.090)

**Side View Dimensions:**

- Overall height: 6.22 (.245)
- Overall height: 5.97 (.235)
- Overall height: 4.57 (.180)

**Callouts:**

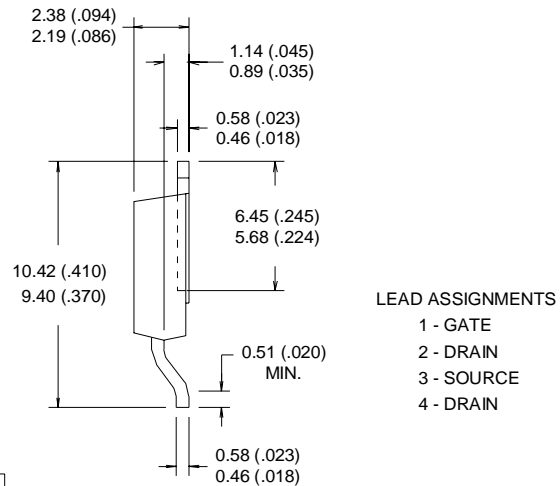
- A**: Top flange
- B**: Bottom flange
- 4**: Top flange

**Feature Callouts:**

- 2X 1.14 (.045) 0.76 (.030)
- 3X 0.89 (.035) 0.64 (.025)

**Feature Callouts:**

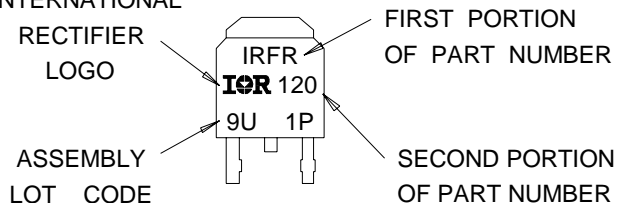
- ⊕ 0.25 (.010)
- Ⓜ A Ⓜ B



1 DIMENSIONING & TOLERANCING PER ANSI Y14.5M, 1982.  
2 CONTROLLING DIMENSION : INCH.  
3 CONFORMS TO JEDEC OUTLINE TO-252AA.  
4 DIMENSIONS SHOWN ARE BEFORE SOLDER DIP,  
SOLDER DIP MAX. +0.16 (.006).

**TO-252AA (D-PARK)**

INTERNATIONAL  
RECTIFIER  
LOGO

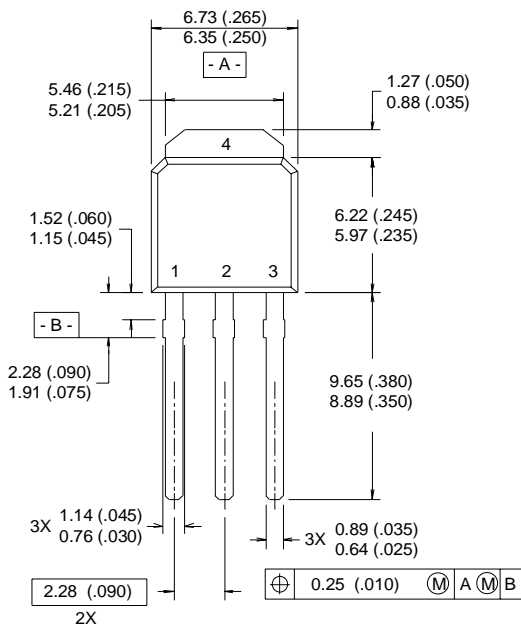




## Package Outline

### TO-251AA Outline

Dimensions are shown in millimeters (inches)



#### LEAD ASSIGNMENTS

- 1 - GATE
- 2 - DRAIN
- 3 - SOURCE
- 4 - DRAIN

#### NOTES:

- 1 DIMENSIONING & TOLERANCING PER ANSI Y14.5M, 1982.
- 2 CONTROLLING DIMENSION : INCH.
- 3 CONFORMS TO JEDEC OUTLINE TO-252AA.
- 4 DIMENSIONS SHOWN ARE BEFORE SOLDER DIP, SOLDER DIP MAX. +0.16 (.006).

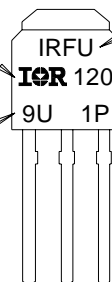
## Part Marking Information

### TO-251AA (I-PARK)

EXAMPLE : THIS IS AN IRFU120  
WITH ASSEMBLY  
LOT CODE 9U1P

INTERNATIONAL  
RECTIFIER  
LOGO

ASSEMBLY  
LOT CODE



FIRST PORTION  
OF PART NUMBER

SECOND PORTION  
OF PART NUMBER

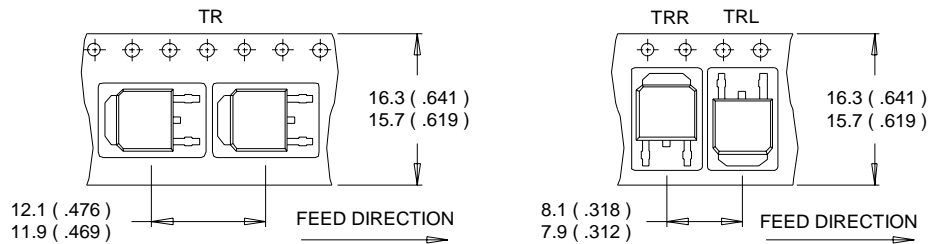
# IRLR/U2705

International  
**IR** Rectifier

## Tape & Reel Information

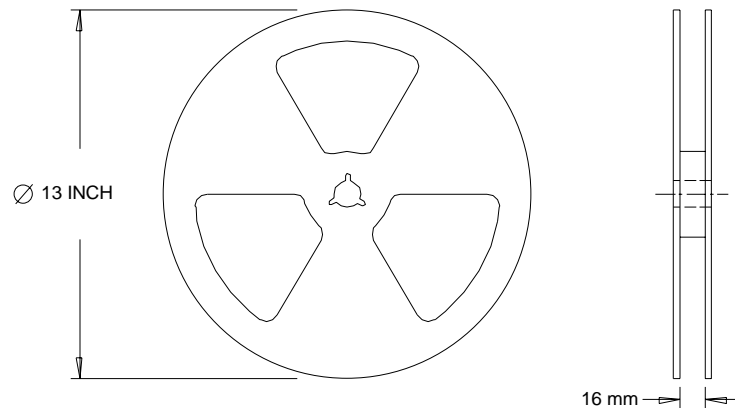
### TO-252AA

Dimensions are shown in millimeters (inches)



#### NOTES :

1. CONTROLLING DIMENSION : MILLIMETER.
2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS ( INCHES ).
3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



#### NOTES :

1. OUTLINE CONFORMS TO EIA-481.

International  
**IR** Rectifier

**WORLD HEADQUARTERS:** 233 Kansas St., El Segundo, California 90245, Tel: (310) 322 3331

**EUROPEAN HEADQUARTERS:** Hurst Green, Oxted, Surrey RH8 9BB, UK Tel: ++ 44 1883 732020

**IR CANADA:** 7321 Victoria Park Ave., Suite 201, Markham, Ontario L3R 2Z8, Tel: (905) 475 1897

**IR GERMANY:** Saalburgstrasse 157, 61350 Bad Homburg Tel: ++ 49 6172 96590

**IR ITALY:** Via Liguria 49, 10071 Borgaro, Torino Tel: ++ 39 11 451 0111

**IR FAR EAST:** K&H Bldg., 2F, 30-4 Nishi-Ikebukuro 3-Chome, Toshima-Ku, Tokyo Japan 171 Tel: 81 3 3983 0086

**IR SOUTHEAST ASIA:** 315 Outram Road, #10-02 Tan Boon Liat Building, Singapore 0316 Tel: 65 221 8371

<http://www.irf.com/> Data and specifications subject to change without notice. 4/03